HP 2892A/12924A
CARD READER SUBSYSTEM DIAGNOSTIC
for
hp 2100 SERIES COMPUTERS

## reference manual

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## 1-1. GENERAL

The purpose of this program is to check and exercise the HP 2892A Card Reader with its interface. Any hardware malfunction will be detected. The program is designed in such a manner that it will also aid the operator in detecting specific components that failed.

## 1-2. REQUIRED HARDWARE

The following hardware is required:
a. HP 2100 series computer with a minimum 4 K memory.
b. An HP 12924A interface with a 2892A Card Reader.
c. A paper tape reading device (used only for loading).
d. A console teleprinter device for message reporting (recommended but not required).
e. Optional: Time Base Generator, HP 12539 (for READ RATE TEST).

## 1-3. REQUIRED SOFTWARE

The following software is required:
a. Diagnostic Configurator Product No. 24296 used for equipment configuration and as a console device driver. The product includes the following part no.: Binary object tape Part No. 24296-60001 Manual Part No. 02100-90157
b. HP 2892A Card Reader Diagnostic binary object tape, Part Number 12924-16001.
c. One card deck consisting of 50 identical cards prepunched with the worst case pattern. See Figure 4-3. This card deck Part Number 12924-90004 was shipped with the interface kit.

PROGRAM ORGANIZATION

## 2-1. ORGANIZATION

The diagnostic is grouped in four functional blocks. Each block will be explained in detail later in the text. The four blocks are Control, Message Reporting, Functional Tests and pseudo Operator Design.

The functional tests (each test is covered under Diagnostic Performance in section IV) are set up to check basic functions first, then move to more complex functions. The functions will cover:
a. Basic $I / O$ control (flag and interrupt for HP 2100 series interface).
b. Status Reporting (card reader ready, off line, picker trouble, etc.).
c. Timing (from pick command to first column, between columns, and column 80 to End-of-Operation).
d. Data Pattern (worst case)
e. Read Rate (cards per minute).
f. Direct Memory Access Transfer (also using a worst case pattern).

2-2. TEST CONTROL AND EXECUTION
The program outputs a title message to the console device for operator information then executes the tests according to the options selected by the operator on the switch register. The control section primarily checks switch register bits 12, 13 and 15. If set, bit 12 is used to loop on the diagnostic, bit 13 is used to loop on a given test that is running at the time. Bit 15 , if set, will halt the computer at the completion of a test.

The control block also keeps count of the number of passes that have been completed and will output the pass count at the completion of each pass (if switch register bit 10 is clear). The count will be reset only if the program is restarted.

Test sections are executed one after another in each diagnostic pass. User selection or default will determine which test sections will be executed.

## 2-3. TEST SELECTION

The control portion of the program enables the operator to select his own test, or sequence of tests. Set switch register bit 9 to indicate operator test selection desired then pressed RUN. The computer will halt (102075) to indicated it is ready for the selection. If the program is running a test, that test will be completed. The program will then halt. The operator then loads the A-register with test selections. A-register bit $\varnothing$ represents Test 00 , bit 1 represents Test 01 , and so on. Bit 6 represents Test 06 , the highest possible selection. The operator must clear switch register bit 9 and press RUN to continue. The selection will then be run. If the operator clears all bits on the A-register, the standard sequence will be run.

Table 2-1 Test Selection Summary

| A-REGISTER BIT | IF SET WILL EXECUTE |
| :---: | :---: |
| $\begin{gathered} 0 \\ 1 \\ 2 \\ 3 \\ 4 \\ 5 \\ 6 \\ 7-15 \end{gathered}$ | Test $\varnothing \varnothing$ BASIC I/O <br> Test $\varnothing 1$ STATUS <br> Test $\varnothing 2$ TIMING <br> Test Ø3 DATA PATTERN <br> Test Ø4 READ RATE <br> Test Ø5 DMA TRANSFER <br> Test Ø6 PSEUDO OPERATOR DESIGN <br> Reserved |
| NOTE: The B-Register is reserved |  |

The standard set of tests consists of tests $\varnothing \varnothing$ through $\varnothing 5$. If operator selection is not requested, or if operator selection is requested and the $A-r e g i s t e r ~ i s ~ c l e a r e d, ~ t h e ~ d e f a u l t ~ c a s e ~ t e s t s ~ \emptyset \varnothing ~ t h r o u g h ~ \emptyset 5 ~ w i l l ~ b e ~ e x-~$ ecuted. If operator selection is requested and A-register bits 7 through 15 or any B-register bits are set, they will be ignored. Only the valid A-register bits 0 through 6 have any meaning.

## 2-4. MESSAGE REPORTING

There are two types of messages, error and information. Error messages are used to inform the operator of the failure of the Card Reader to respond to a given control or sequence. Information messages are used to inform the operator of the progress of the diagnostic or instruct the operator to perform some operation related to Card Reader functions. In the last case mentioned an associated halt will occur to allow the operator time to perform the function. To continue the operator must press RUN.

If a console device is used, the printed message will be preceded by an E (error) or $H$ (information) and a number (in octal). The number is also related to the halt code when a console device is not available.

Example - Error with halt
Message: Eø13 SECOND INT OCCURRED (CONSOLE DEVICE)
Halt Code: $1 \varnothing 2 \varnothing 13_{8}$ (T-or Memory Data Register)
Example - Information with halt

Message: Hø24 PRESS PRESET, THEN RUN
Halt Code: $1 \not 02 \not 024_{8}$
Refer to table 4-1 for specific meanings.
Example - Information only

```
Message: H\emptyset25 BI-0 COMP
```

Halt Code: None

Error messages can be suppressed by selection of the switch register bit 11 and error halts can be suppressed by switch register bit 14. This is useful when looping on a single section that has several errors.

Information messages are suppressed by switch register bit 10.

## 2-5. PROGRAM LIMITATIONS

Checking the interface for capability of receiving, passing and denying priority is not completely checked by this diagnostic. If the interface does not receive priority ( PRH from next lower select code) an error Eøl4 NO INT will occur. To check this, remove an interface having a lower select code and run the Basic I/O test and the above mentioned error should occur. Checking the interface ability to pass or deny priority is beyond the scope of this diagnostic.

3-1. LOADING BINARY TAPES AND CONFIGURING
a. Load Diagnostic configurator binary object tape. If it is a configured version skip to step b. Configure program according to the Diagnostic Configurator M.O.D.*
b. The operator may dump a configured Diagnostic Configurator binary object tape at this point.
c. Load main diagnostic binary object tape. At this point a binary tape of the combined configurator and diagnostic may be dumped using the configurator dump routine.
d. If a preconfigured binary tape was loaded, go to paragraph 3-2.
e. Load p-register with the starting address $1 \varnothing_{8}$.
f. Load the switch register with the select codes of the Card Reader under test (bits ø-5 for CR I/O select code) and the Time Base Generator (HP 12539) if available (bits 9-14 for TBG I/O select code).
g. Press PRESET (INT/EXT) and press RUN. The computer will run than halt with $1 \varnothing 2 \varnothing 748$ in the MEMORY DATA register. If halt $102073_{8}$ occurs, one of the select codes input was less than or equal to 78 ; correct the select code and press RUN.

At this point the operator may dump to paper tape a copy of the configured program. Refer to the M.O.D.* for the configurator dump routine operation instructions. If this is done, the operator must set the P-register equal to $2 \varnothing \varnothing \varnothing_{8}$ before continuing to the next section.

3-2. SWITCH REGISTER SELECTION AND RUNNING
a. If a preconfigured tape was loaded set the $P-r e g i s t e r ~ e q u a l ~ t o ~ 2 \varnothing \varnothing \varnothing_{8}$, if not skip this step.
b. Make selection of switch register options according to table 3-1.
*M.O.D. - Manual of Diagnostics

Table 3-1. Switch Register Settings

| BIT | MEANING IF SET |
| :---: | :---: |
|  | Loop on Pseudo Operator Design <br> Check for ready <br> pseudo <br> Read a card and put data in read buffer operator <br> Compare read buffer with standard data pattern design only <br> List read buffer <br> Delay 1 second between picks <br> Print Status <br> Reserved <br> Reserved <br> Abort current diagnostic execution and halt (1ø2ø75); user may specify a new group of tests in the A-register, clear bit 9 and then press RUN. <br> Suppress non-error messages. <br> Suppress error messages <br> Repeat all selected tests after diagnostic run is complete without halting. Message "PASS Xxxxxx" will be output before looping unless bit $1 \varnothing$ is set or teletype is not present. Also those tests requiring operator intervention will be suppressed. <br> Repeat last test executed (loop on test). <br> Suppress error halts. <br> Halt (1ø2ø76) at the end of each test; the A-register will contain the test number in octal. |

If switch register is cleared, the program will execute all tests (except pseudo Operator Design) and halt with $1 \varnothing 2 \varnothing 77$ in the data register. It is suggested that this be done on the first pass of the diagnostic.
C. Press PRESET (INT/EXT) and press RUN. The program will now execute the diagnostic according to the switch register options. At the completion of each pass of the diagnostic the pass count is output to the console for operator information. If switch register bit 12 was not selected the computer will halt with $1 \varnothing 2 \varnothing 77_{8}$ in the memory data register. At this point the A-register contains the pass count. To run another pass the operator need only press RUN .
d. The program may be restarted by setting the p-register to $2 \not \varnothing_{8}$ and proceeding from step b above.
e. To restart and reconfigure, proceed from paragraph 3-1, step e.
f. If a trap cell halt occurs ( $1 \varnothing 6 \varnothing 77$ ), the user must determine the cause of the interrupt of transfer of control to the location in the M-register. The program may need to be reloaded to continue.

## 3-3. PSEUDO OPERATOR DESIGN

This section is mainly designed to aid the operator in trouble shooting and repairing the card reader or interface. The operator must select test 6 to enter Pseudo Operator Design. When entered, the program will output to the console (if available and switch register bit 10 is cleared) "Hll7 PSEUDO OPDESIGN" indicating the program has been entered then halt with $1 \varnothing 6 \varnothing 17$ displayed. At this point the operator selects what he wants the program to do by setting the appropriate switch then presses RUN. The program will sequentially scan the switch register for selected functions and will perform each then halt with $1 \not{ }^{1} \varnothing 17_{8}$ again. If the operator wishes to loop on the selected functions, he may do so by selecting switch zero.

| SWITCH | MEANING IF SET |
| :---: | :--- |
| $\varnothing$ | Loop on Pseudo Opdesign |
| 1 | Check for card reader ready (BIT $\varnothing$ ) |
| 2 | Read a card and put data in read buffer |
| 3 | Compare read buffer with Standard Pattern |
| 4 | List Read Buffer |
| 5 | Delay I second before next READ |
| 6 | Print current CR Status (does not halt) |

After the first pass, the A-register will contain the current status of the card reader at halt $1 \varnothing 6 \varnothing 178^{\circ}$. To exit Pseudo Operator Design, clear switches $\varnothing-6$ and press RUN.

The routines used for switches 1,2 and 3 are common to other tests.
Switch 1 - Check for ready
If the Card Reader is found ready the program will continue. If the Card Reader is found not ready (Bit $0=1$ ), the program will output the message "H055 CR NOT READY" and then halt ( $102055_{8}$ ). To continue; make the Card Reader ready and press RUN. If the Card Reader is still not ready, the message will be output
again. This will continue until the Card Reader is ready or switch 1 is cleared.
Switch 2 - Read a card

This routine reads a card and puts the data in a buffer for later reference. The program allows 1 second response time before an error is reported and checks that 80 columns have been read. The messages are "El30 CR TIMED OUT" and "El3l EOP BEFORE 80 COLUMNS."

Switch 3 - Compare Buffer
This checks the data read with the standard worse case pattern. If any data is found in error, the message "H132 DATA ERROR ACT XXXX EXP YYYY" will be output for each error. When the computer is halted, the $A-r e g i s t e r=X X X X$ and the $B$-register $=$ YYYY.

Switch 4 - List read buffer

The message "Hl 20 BUFFER LIST" and the buffer contents ( 4 columns) will be output. Column 1 represents columns $1-20$ on the card, column 2 is 21-40, column 3 is $41-60$ and column 4 is $61-80$. The data is in 4 octal numbers reading left (rows 12-11-0) to right (rows 7-8-9). If a console device is not available the computer will halt ( $106020_{8}$ ) with the A register equal to each column.

RUN must be pressed for each column, unless switch 4 is cleared.
Switch 5.- Delay one second
Delay one-second before next scan of switch reqister.
Switch 6 - Print Status
This routine reads the status from the Card Reader and outputs the message "H120 STATUS IS XXXXXX." The computer does not halt for this message. The last status is displayed when halted with $106017{ }_{8}$.

4-1. TEST DESCRIPTION

4-2. BASIC I/O CHECKS

TEST $\varnothing$

Subtest 1 - Checks the ability to clear set and test the interrupt system. The following instruction combinations are tested:

CLF $\varnothing$ - SFC $\varnothing$
CLF $\varnothing$ - SFS $\varnothing$
STF $\varnothing$ - SFC $\varnothing$
STF $\varnothing$ - SFS $\varnothing$

Errors in the above sequences produce error messages Eøøø-Eøø3.

Subtest 2 - Checks the ability to clear, set and test the interface select code. The following instruction combinations are tested:

CLF CH - SFC CH
CLF CH - SFS CH
STF CH - SFC CH
STF CH - SFS CH

Errors in the above sequences produce error messages Eøø5-Eølø.
Subtest 3 - Checks that the test select code does not cause an interrupt with the flag and control set on the interface and the interrupt system is off. The sequence of instructions is shown below:

STF Ø
STF CH
STC CH
CLF $\varnothing$

The CLF $\varnothing$ instruction should inhibit an interrupt from occurring. Error message Eøø4 occurs if CLF $\emptyset$ fails.

Subtest 4 - Checks that the flag of the interface under test is not set when all other select code flags are set. Error message Eøll occurs if the flag is set incorrectly.

Subtest 5 - Checks the ability of the interface to interrupt. With the flag and control set and the interrupt system on, there should be an interrupt on the $I / O$ channel. If not, error message Eøl4 occurs. Checks that the interrupt occured where expected. The interrupt should not occur before a string of priority affecting instructions are executed. The following instructions are used to check the hold-off operation:

STC 1
STF 1
CLC 1
CLF 1
JMP *+1,I
DEF *+1
JSB * $+1, I$
DEF *+1
NOP

Error messages $E \nsupseteq 12$ and $E \nsupseteq 15$ will occur if this is not true. Checks that another interrupt doesn't occur when the interrupt system is turned back on. Error message Eøl3 will occur if this is not true. Checks that no instruction was missed during the interrupt (Eø26 INT EXECUTION ERROR).

Subtest 6 - Checks that with the interrupt system on and the constol $F F$ and flag FF set, there is no interrupt following a CLC CH instruction. The following sequence of instructions are used.

STC CH
STF CH
STF $\varnothing$
CLC CH

If the CLC CH fails to inhibit an interrupt, error message Eøl6 will occur.

Checks that the CLC $\varnothing$ instruction inhibits interrupts when the control FF and flag FF are set. The following sequence of instructions is used.

CLF CH
STC CH
STF CH
STF $\varnothing$
CLC Ø
If the CLC $\varnothing$ fails to inhibit an interrupt, error message $E \varnothing 17$ will occur.

Subtest 7 - Checks that the PRESET (EXTERNAL and INTERNAL if applicable) switches on the computer front panel performs the following actions:

1. Sets all flags (EXTERNAL).
2. Clears all control (EXTERNAL).
3. Turns off the interrupt system (INTERNAL).
4. Clears the I/O data lines (EXTERNAL).

## 4-3. STATUS TEST

The Status Tests check that the correct status is reported from the interface and card reader. Some checks require manual operation by the operator. The program first checks status when the reader if off and on. Then continues to check the interface status and operation. The program then moves to check the status reported from the reader by forcing errors with specially prepared cards. The following is a description of the necessary cards:
a. Two half cards and two standard cards. These are used to generate a card motion error by placing the half cards in the stacker and the two standard cards in the hopper. When the program reads the first card the front edge will hit the two half cards and block the stacker photo cell. When the second card is read, the card motions error should occur.
b. A card with a $1 / 4$ inch square notch torn from the leading edge. This card is used to check the Dark Check error detection circuitry.
c. Two cards hooked together from approximately column 80 to the back edge of the card. These are used to check the pick failure detection circuitry.

Tear out notch


The following sequence is used to check status.
(CR $=$ card reader). Step numbers are in octal and correspond to Status Error halts if octal 30 is added. For status test, operator instructions must be followed exactly.

1. Turn CR power off.
A. $O F F-L I N E=\varnothing$
B. "NOT" READY = 1
(BIT 2)
(BIT Ø)
2. Turn CR power on
A. OFF-LINE $=\varnothing$
(BIT 2)
B. "NOT" READY = 1
(BIT ø)
3. Give PICK command (STC CR,C).
A. $\quad$ PICK $=1$
(BIT 8)
B. $R I P=1$
(BIT 12)
C. $E O P=\varnothing$
(BIT 15)
4. Put $C R$ in OFF-LINE mode
A. OFF-LINE $=1 \quad$ (BIT 2)
B. $P I C K=\varnothing$ (reset by OFF-LINE) (BIT 8)

C EOP = 1
(BIT 15)
D. "NOT" READY $=\varnothing$
(BIT $\varnothing$ )
E. $\quad$ RIP $=1$
(BIT 12)
F. PLAG SET BY OFF-LINE and PICK
5. Give PICK command (STC CR,C when in OFF-LINE).
A. $\quad$ PICK $=\varnothing$ (prevented by OFF-LINE) (BIT 8)
B. $\mathrm{RIP}=1 \quad$ (BIT l2)
C. $\mathrm{EOP}=1 \quad$ (BIT 15)
6. Put $C R$ in ON-LINE mode. Load three cards. Start CR.
A. OFF-LINE TO ON-LINE

SETS FLAT WHEN CONTROL SET AND $\overline{-} \overline{R I P}=1$
B. All bits indicate ready
7. Extend Stacker Arm and hold (should cause STOP).
A. "NOT" Ready $=1$
(BIT Ø)
B. STACKER FULL $=1$
(BITS 5 \& 6)
10. Give PICK command (STC CR,C).
(now CLC CR,C clears PICK)
A. $\quad \mathrm{PICK}=\varnothing$
11. Release Stacker Arm and Start CR.
A. ALL BITS INDICATE READY
12. Pick two cards (STC CR,C).
A. CHECK LOST DATA
(BIT 3)
(NO LIA during read)
B. CHECK LOST DATA
(BIT 3)
(OTA but no LIA)
13. Press END-OF-FILE
A. END-OF-FILE $=1$
(BIT 7)
B. HOPPER EMPTY = 1
(BIT 5)
14. Load two half cards in the STACKER and two standard cards in the HOPPER. Press START on CR.
A. ALL BITS INDICATE READY
15. Pick card (First interrupt GENERATE CRS) .
A. $\overline{R I P}=1$
(Bit 12)
B. $E O P=1$
(BIT 15)
C. $\quad \mathrm{PICK}=\varnothing$
(BIT 8)
16. Pick card
A. TROUBLE $=1$
(BIT 1)
B. MOTION/PICK $=1$
(BIT 11)
17. Load NOTCHED card. Press START on CR. Press RUN.
A. ALL BITS INDICATE READY
20. Pick the card
A. TROUBLE $=1$
(BIT 1)
B. ERROR L/D = 1
(BIT 9)
21. Load two cards taped together.

Press START on CR. Press RUN.
A. ALL BITS INDICATE READY
22. Pick the card
A. TROUBLE $=1$
(BIT 1)
B. MOTION $/ \mathrm{PICK}=1$
(BIT 11)

4-4. TIMING TESTS
This test requires 10 cards be placed in the CR. The program will pick each card and verify the timing on each (all data is ignored). The timing checks are as follows:

$$
4-5
$$



FIGURE 4-2 Card Reader Timing Chart
A. Normal 24 to 27 milliseconds (time from pick to first int.) If greater than 27 but less than 40 then possible picker trouble. If over 40 but less than 300 then more than one pick attempt. If over 300 , status should indicate pick failure. Maximum allowance is 1 second then no EOP is assumed.
B. Normal $870 \mu \mathrm{sec}$ (time between data). If greater than 1 millsecond, the CR is in error and a message is output to the operator.
C. Normal 3480 usec (time from last data to EOP). If greater than 4 milliseconds the CR is in error and a message is output to the operator.

During the above checks the number of flags received is also checked to insure 80 Data Columns have been read for each card. Any data is ignored.

4-5. DATA PATTERN TEST

This checks a worst case data pattern. The cards are supplied with the Card Reader and have the worst case pattern prepunched. There will be 50 cards read and the data verified.


FIGURE 4-3. Worst Case Data Pattern Card

## 4-6. READ RATE TEST

This will read 50 cards and from that determine the cards-per-minute read rate. This reading is only accurate to +5 cards per minute if a TBG is not specified during configuration. A variation of a few cards per minute can be expected between old and new cards, how full the hopper is, if the cards are bent, etc. The CPR reading will be output to the console device if available or a halt with the A-register equal to the octal representation of the number.

4-7. DMA TRANSFER TEST

In this test, the program reads the same 50 cards as the Data Pattern test except using the DMA portion of the computer and interface card. The test will only be executed if DMA is available.

## 4-8. ERROR INFORMATION MESSAGES AND HALT CODES

Table 4-1 summarizes the diagnostic halt codes and table 4-2 defines the card reader status bits.

Table 4-1. Error Information Messages and Halt Codes

| HAIT CODE | SECTION | MESSAGE | COMMENTS |
| :---: | :---: | :---: | :---: |
| 1ø2073 | Configuration | None | I/O select code entered at configuration invalid. Must be greater than ${ }^{7} 8$. <br> Re-enter a valid select code and press RUN. |
| 102074 | Configuration | None | Select code entered during configuration valid. Enter program option bits in switch register and press RUN. |
| 1ø2ø75 | Test Control | None | Test selection request resulting from switch register bit 9 being set. Enter in $A / B-r e g i s t e r s$ the desired group of tests to be executed and press RUN. |
| $\begin{aligned} & 1 \varnothing 2 \varnothing 76 \\ & \text { A REG = } \\ & \text { TEST } \\ & \text { NUMBER } \end{aligned}$ | Test Control | None | End of test halt resulting from switch register bit 15 being set (A-register has the test number). To continue press RUN. |
| $1 \varnothing 2 \varnothing 77$ <br> A REG = PASS COUNT | Test Control | PASS XXXXXX | Diagnostic run complete. Register options may be changed. To continue press RUN |
| 196077 | Test Control | None | Halt stored in location $2-77_{8}$ to trap interrupts which may occur unexpectedly because of hardware malfunctions. M-register contains the I/O slot which interrupted. Diagnostic may be partially destroyed if halt occurs. The program may have to be reloaded; the problem should be corrected before proceeding. |
| 1ø2øøø | Test $\varnothing$ | Eøøø CLF $\varnothing$-SFC Ø ERROR | CLF/SFC $\varnothing$ combination failed. CLF did not clear flag or SFC caused no skip with flag clear. |

Table 4-1. Error Information Messages and Halt Codes

| HALT CODE | SECTION | MESSAGE | COMMENTS |
| :---: | :---: | :---: | :---: |
| 1ø2øø1 | Test $\varnothing$ | Eøøl CLF $\varnothing$-SFS $\varnothing$ ERROR | CLF/SFS $\varnothing$ combination failed. CLF did not clear flag or SFS caused skip with flag clear. |
| 1ø2øø2 | Test $\varnothing$ | Eøø2 STF $\varnothing$-SFC $\varnothing$ ERROR | STF/SFC $\varnothing$ combination failed. STF did not set flag or SFC caused skip with flag set. |
| $1 \varnothing 2 \varnothing \varnothing 3$ | Test $\varnothing$ | Eøø3 STF $\varnothing$-SFS $\varnothing$ : ERROR | STF/SFS $\varnothing$ combination failed. STF did not set flag or SFS caused no skip with flag set. |
| $1 \varnothing 2 \varnothing 04$ | Test $\varnothing$ | Eøø4 CLF Ø DID NOT INHIBIT INT | With card flag and control set, CLF $\varnothing$ did not turn off interrupt system. |
| 1ø2øø5 | Tese $\varnothing$ | Eøø5 CLF CH-SFC CH ERROR | CLF/SFC CH combination failed. CLF did not clear flag or SFC caused no skip with flag clear. |
| $1 \varnothing 2 \varnothing \varnothing 6$ | Test $\varnothing$ | Eøø6 CLF CH-SFS CH ERROR | CLF/SFS CH combination failed. CLF did not clear flag or SFS caused skip with flag clear. |
| $1 \varnothing 2 \varnothing \varnothing 7$ | Test $\varnothing$ | Eøø7 STF CH-SFC CH ERROR | STF/SFC CH combination failed. STF did not set flag or SFC caused skip with flag set. |
| $1 \varnothing 2 \varnothing 1 \varnothing$ | Test $\varnothing$ | Eøl $\varnothing$ STF CH-SFS CH ERROR | STF/SFS CH combination failed. STF did not see flag or SFS caused no skip with flag set. |
| $\begin{gathered} 1 \varnothing 2 \varnothing 11 \\ \text { AREG }^{\prime}= \\ {x x_{8}}^{2} \end{gathered}$ | Test $\varnothing$ | Eøll STF XX SET CARD FLAG | Select code screen test failed. xX $=$ select code that caused that card flag to set. |
| $1 \varnothing 2 \varnothing 12$ | Test $\varnothing$ | Eø12 INT DURING HOLD OFF INSTR | Interrupt occured during an I/O instruction or a JMP/JSB indirect instruction. |

Table 4-1. Error Information Messages and Halt Codes (Continued)

| HALT CODE | SECTION | MESSAGE | COMMENTS |
| :---: | :---: | :---: | :---: |
| 102013 | Test $\varnothing$ | Eø13 SECOND INT OCCURRED | Interface interrupted a second time after initial interrupt was processed |
| 102014 | Test $\varnothing$ | Eø14 NO INT | No interrupt occured with interface flag and control set and the interrupt system on. |
| 1ø2ø15 | Test $\varnothing$ | Eø15 INT RTN ADDR ERROR | Interrupt did not occur at the correct location in memory. |
| 182016 | Test $\varnothing$ | Eø16 CLC CH ERROR | CLC CH did not clear interface control with the interrupt system on. |
| 182017 | Test $\varnothing$ | Eø17 CLC Ø ERROR | CLC $\varnothing$ did not clear control with the interrupt system on. |
| 1ヵ2ø2ø | Test $\varnothing$ | EØ2ø PRESET (EXT) DID NOT SET FLAG | PRESET (EXT) did not set the interface flag. |
| 182021 | Test $\varnothing$ | EØ21 PRESET (INT) DID NOT DISABLE INTS | PRESET (INT) did not disable the interrupt system. |
| 1ه2022 | Test $\varnothing$ | Eø22 PRESET (EXT) DID NOT CLEAR CONTROL | PRESET (EXT) did not clear control. |
| 182023 | Test $\varnothing$ | EØ23 PRESET (EXT) DID NOT CLEAR I/O LINES | PRESET (EXT) did not clear I/O data lines. |
| 182824 | Test $\varnothing$ | HO24 PRESS PRESET (EXT \& INT), RUN | Press PRESET (External, Internal), RUN. |
| NONE | Test $\varnothing$ | H025 BI-O COMP | Basic I/O Tests completed |
| 1ø2026 | Test $\varnothing$ | E $\varnothing 26$ INT EXECUTION ERROR | Interrupt was not processed correctly. |
| NONE | Test Control | 2892A CARD READER DIAGNOSTIC | Introductory message. |

Table 4-1 Error Information Messages and Halt Codes (Continued)

| HALT CODE | SECTION | MESSAGE | COMMENTS |
| :---: | :---: | :---: | :---: |
| NONE | Test <br> - Control | TEST XX | Information message before error message ( $X X=$ test number). Message occurs only once within a test but is suppressed for any subsequent messages within the same test. |
| $1 \varnothing 2 \varnothing 3 \varnothing$ | Test 1 | E030 CR TIMED OUT | The card reader failed to respond to a pick command. Refer to Status test steps 12, 13, 16 and 20. |
| $1 \varnothing 2 \varnothing 31$ | Test 1 | E031 STATUS IS XXXXXX AND EXPECTED 110001 | Refer to Status test Step 1. <br> $A=$ Current Status <br> $B=$ Expected Status |
| $1 \varnothing 2 \varnothing 32$ | Test 1 | E032 STATUS IS XXXXXX AND EXPECTED 110041 | Refer to Status test Step 2 $A=\text { Current Status }$ $B=\text { Expected Status }$ |
| $1 \varnothing 2 \varnothing 33$ | Test 1 | E033 STATUS IS XXXXXX AND EXPECTED 010441 | Refer to Status test Step 3. <br> $A=$ Current Status <br> $B=$ Expected Status |
| $1 \varnothing 2 \varnothing 34$ | Test 1 | E034 STATUS IS XXXXXX AND EXPECTED 110045 | ```Refer to Status test Step 4. A = Current Status B = Expected Status``` |
| 1ه2ø35 | Test 1 | E035 STATUS IS XXXXXX AND EXPECTED 11045 | Refer to Status test Step 5 <br> $\mathrm{A}=$ Current Status <br> $B=$ Expected Status |
| $1 \varnothing 2 \varnothing 36$ | Test 1 | E036 STATUS IS XXXXXX AND EXPECTED 110000 | ```Refer to Status Report Step 6 A = Current Status B = Expected Status``` |
| $1 \varnothing 2037$ | Test 1 | E037 STATUS IS XXXXXX AND EXPECTED 110141 | Refer to Status test Step 7 <br> A = Current Status <br> $B=$ Expected Status |
| $1 \varnothing 2 \varnothing 4 \varnothing$ | Test 1 | E040 STATUS IS XXXXXX AND EXPECTED Ol01.41 | ```Refer to Status test Step l0 A = Current Status B = Expected Status``` |
| $1 \varnothing 2041$ | Test 1 | E041 STATUS IS XXXXXX AND EXPECTED 010000 | Refer to Status test Step 11 <br> $A=$ Current Status <br> $B=$ Expected Status |

Table 4-1 Error Information Messages and Halt Codes (Continued)

| halt code | SECTION | MESSAGE | COMMENTS |
| :---: | :---: | :---: | :---: |
| 1 102ø42 | Test 1 | E042 STATUS IS XXXXXX AND EXPECTED 110012 | Refer to Status test Step 12 <br> $\mathrm{A}=$ Current Status <br> B $=$ Expected Status |
| 182843 | Test 1 | EO43 STATUS IS XXXXXX AND EXPECTED 110241 | Refer to Status test Step 13. <br> $\mathrm{A}=$ Current Status <br> B = Expected Status |
| $1 \varnothing 2 \varnothing 44$ | Test 1 | E044 STATUS IS XXXXXX AND EXPECTED 110000 | Refer to Status test Step 14. <br> $\mathrm{A}=$ Current Status <br> B $=$ Expected Status |
| 182845 | Test 1 | E045 STATUS IS XXXXXX <br> AND EXPECTED 110001 | Refer to Status test Step 15. <br> $\mathrm{A}=$ Current Status <br> B = Expected Status |
| 1ø2ø46 | Test 1 | E046 STATUS IS XXXXXX AND EXPECTED 114043 | Refer to Status test Step 16. <br> $\mathrm{A}=$ Current Status <br> B = Expected Status |
| $1 \varnothing 2 ø 47$ | Test 1 | E047 STATUS IS XXXXXX AND EXPECTED 110000 | Refer to Status test Step 17. <br> $\mathrm{A}=$ Current Status <br> B = Expected Status |
| 1ø2ه5 ${ }^{\text {d }}$ | Test 1 | E050 STATUS IS XXxxxx AND EXPECTED 111043 | Refer to Status test Step 20. <br> $\mathrm{A}=$ Current Status <br> B = Expected Status |
| 1ø2ø51 | Test 1 | E051 STATUS IS Xxxxxx AND EXPECTED 110000 | Refer to Status test Step 21. <br> $\mathrm{A}=$ Current Status <br> B $=$ Expected Status |
| $1 \varnothing 2 \varnothing 52$ | Test 1 | E052 STATUS IS XXXXXX AND EXPECTED 114003 | Refer to Status test Step 22. <br> $\mathrm{A}=$ Current Status <br> B = Expected Status |
| 182853 | Test 1 | E053 FLAG NOT SET OFF-LINE + PICK | Refer to Status test Step 4. |
| $1 \varnothing 2 \varnothing 54$ | Test 1 | EO54 FLAG NOT SET OFF-TO-ON LINE | Refer to Status test Step 6. |
| 1ø2ه55 | Test 2-6 | E055 CR NOT READY | The Card Reader was found not ready by checking bit $0=0$. The Card Reader can be made ready and RUN. |

Table 4-1 Error Information Messages and Halt Codes (Continued)

| halt Code | SECTION | MESSAGE | COMMENTS |
| :---: | :---: | :---: | :---: |
| 1ø2ø56 | Test 2 | E056 EOP BUT NO INTERRUPT | pressed. If the program still finds the Card Reader not ready the test is aborted. <br> A pick command was given to the CR but no interrupt occurred after 1 second. When checking status EOP was found high which indicates an interrupt should have occurred. |
| $1 \varnothing 2 \varnothing 57$ | Test 2 | E057 NO EOP AFTER PICK | After giving a pick command no interrupt occurred and checking status indicated EOP $=\varnothing$. |
| 1ヵ2ø6ø | Test 2 | E060 PICK FAILURE | Card Reader failed to pick card |
| $1 \varnothing 2 \varnothing 61$ | Test 2 | E061 PICK TO INT OVER 300 MS | Refer to Timing test Part A. |
| $1 \varnothing 2 \varnothing 62$ | Test 2 | E062 POSSIBLE PICKER TROUBLE | Refer to Timing test Part A. |
| $1 \varnothing 2 \varnothing 63$ | Test 2 | E063 EOP BEFORE 80 COLUMNS | During Timing test EOP occurred before all 80 columns had been checked. |
| $1 \varnothing 2 \varnothing 64$ | Test 2 | E064 TIME BETWEEN <br> DATA OVER lMS | Refer to Timing test Part B. |
| $1 \varnothing 2 \varnothing 65$ | Test 2 | E065 80 COLUMNS BUT NO EOP | The full 80 columns were read but no EOP occurred within 1 second after the last data column. |
| $1 \varnothing 2 \varnothing 66$ | Test 2 | E066 DATA TO EOP OVER 4 MS | Refer to Timing test Part C. |
| $1 \varnothing 2 \varnothing 67$ | Test 2 | E067 INT TIME OUT DURING READ | More than 1 second elapsed between data columns. |
| 1ø6øø | Test 1 | HI $\varnothing \varnothing$ TURN CR POWER off and remove any CARDS |  |
| 106001 | Test 1 | H1O1 TURN CR POWER ON |  |

Table 4-1 Error Information Messages and Halt Codes (Continued)

| HALT CODE | SECTION | MESSAGE | COMMENTS |
| :---: | :---: | :---: | :---: |
| 106øø2 | Test 1 | H1O3 PUT ER ON-LINE LOAD THREE CARDS START CR |  |
| 186888 | Test 1 | H104 EXTEND STOCKER ARM AND HOLD |  |
| 186085 | Test 1 | H105 RELEASE STACKER ARM START CR |  |
| 186886 | Test 1 | H106 PRESS CR END-OF-FILE |  |
| 106087 | Test 1 | H107 LOAD SHORT CARDS AND TWO LONG CARDS START CR | Two short cards in stacker and long cards in hopper. |
| 106ø1ø | Test 1 | HllO LOAD NOTCHED CARD START CR |  |
| 186011 | Test 1 | Hlll LOAD 2 CARDS HOOKED TOGETHER |  |
| $186 \varnothing 12$ | Test 2 | H112 LOAD TEN CARDS FOR tIMING teSt and Start CR |  |
| 10601.3 | Test 3 | H113 LOAD 50 CARDS FOR DATA PATTERN CHECK START CR |  |
| 196ø14 | Test 4 | Hll4 LOAD 50 CARDS FOR READ RATE AND START CR |  |
| $1 \varnothing 6 \varnothing 15$ | Test 4 | Hll5 XXX CARDS PER MINUTE | $x x x=$ The calculated number of cards read per minute. |
| 186016 | Test 5 | H116 LOAD 50 CARDS <br> FOR DMA TEST START CR |  |
| 106017 | Test 6 | H117 PSEUDO OPDESIGN | ```Operator may make switch register function selection then press RUN.``` |
| NONE | Test 6 | H120 STATUS IS XXXXXX | ```Operator selected switch register bit 6 during Pseudo Opdesign.``` |
| 106021 | Test 6 | H121 BUFFER LIST | Operator selected switch register bit 4 during Pseudo Opdesign. A read buffer list will follow, the columns |

Table 4-1 Error Information Messages and Halt Codes (Continued)

| HALT CODE | SECTION | MESSAGE | COMMENTS |
| :---: | :---: | :---: | :---: |
| $1 \phi 6 \varnothing 3 \varnothing$ | Test 3,6 | El30 CR TIMED OUT | are represented 1-20, 21-40, 41-60 and 61-80. <br> During a read operation the card reader failed to respond within 1 sec . |
| 106ø31 | Test 3,6 | El31 EOP BEFORE 80 COLUMNS | During a read operation EOP (bit 15) went high before all 80 columns were read. |
| $1 \varnothing 6032$ | Test 3,6 | El32 DATA ERROR <br> ACT XXXX <br> EXP YYYY | Data read from card reader did not compare with standard data table. When halted $A$ reg $=X X X X$ and $B$ reg $=Y Y Y Y$ |
| 106033 | Test 4 | E133 CR TIMED OUT | During the read rate that the card reader did not respond. |
| 196034 | Test 5 | El34 CR NOT READY | During the read rate test the card reader went not ready. |
| 1ø6035 | Test 5 | El35 DMA TIMED OUT | After starting DMA and giving a pick command there was no response from either DMA or the Card Reader interface. |
| 106036 | Test 5 | El36 DMA TRANSFER | After a DMA transfer, the count left in DMA register was not 5. DMA is asked to transfer 85 data words and therefore should not complete and have a count of 5 left when good transfer takes place. (A=DMA COUNT-LIA 2) |
| $1 \varnothing 6037$ | Test 5 | El37 NO EOP AFTER DMA TRANSFER | After a DMA bit 15 (EOP) of the interface was low and should be high. |
| $1 \varnothing 6 \varnothing 4 \varnothing$ | Test 5 | E140 DMA COMPLETED BEFORE CR | More than 85 data words were transferred to DMA without EOP occurring. |

Table 4-2. Card Reader Status Bits

| BIT | MEANING IF SET |
| :---: | :---: |
| $\varnothing$ | Card Reader not ready or off-line. |
| 1 | Trouble during read <br> a. Card motion <br> b. Light/Dark error <br> c. Data loss |
| 2 | Card Reader is Off-Line |
| 3 | Data lost <br> a. Missed an LIA or LIB <br> b. OTA or OTB but no LIA or LIB during read |
| 4 | Not used |
| 5 | Hopper Empty or Stacker Full |
| 6 | Stacker Full |
| 7 | End-of-File and Hopper Empty |
| 8 | Pick. STC was issued but first column has not been read |
| 9 | Light/Dark check error |
| 10 | Not used |
| 11 | Motion/Pick Check |
| 12 | "NOT" Read in Progress ( $\overline{\mathrm{RIP})}$. Card Reader is not reading a card |
| 13 |  |
| 14 |  |
| 15 | End-of-Operation <br> a. Power on or preset <br> b. Went Off-Line when Pick $=1$ <br> c. Data read complete <br> d. Reader failed to read within 875 $\pm 150 \mathrm{mit} / \mathrm{sec}$. |

